

Search Notes

Application/Control No.

10/764,459

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

MIZUNO ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22-35, 85 17,86,92 6	12/22/2005	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search (see attached)	12/22/2005	SWH